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STATEMENT BY APPLICANT				First Named Inventor	Chambers et al.			
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	(use as many si	neets as necessary)		Examiner Name				
Sheet	1	of	1	Attorney Docket No.	TI-36030			

				U.S. PATENT DOC	UMENTS	
		U.S. Patent Doc	ument	Name of Patentee or	Date of Pub. of	·
Exam. Initials*	Cite No.1	Number	Kind Code ² (if known)	Applicant of Cited Doc.	Cited Doc. (mm- dd-yyyy)	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Examiner	Date	1 02/12/20
Signature	Considered	02/12/03

US and Foreign Patent Documents: ¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

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